Full Simulation of Belle & Belle II SVD Detector (within ILC Framework)

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ILC Software Framework – Summary

- Mokka: Geant 4 based, full simulation tool using a realistic detector geometry (accessible via a MySQL database) → output in *ascii* or *lcio* format
- LCIO: Linear Collider I/O persistency framework, which defines a data model for ILC; data persistency format: Serial Input/Output (SIO) → output in *.slcio file
- *GEAR*: Geometry description toolkit for ILC analysis and reconstruction software → output in **.xml* file



- *Marlin*: ILC Modular C++ Analysis & Reconstruction tool that enables modular approach (using so-called processors) to development of analysis and recon. code (based on LCIO)
- Marlin Reco: Marlin based toolkit providing reconstruction algorithms for data analysis

Mokka & Marlin – What's New in SVD Implementation?

- *Mokka:* 2 new geom. drivers implemented: SVDBelle (SVDv2), VXDBelleII (PXD+SVD) (new sensitive & hit classes implemented as well ...)
 - SVDBelle geom. driver of a current Belle vertex detector 4 layers of DSSDs
 - VXDBelleII geom. driver of a vertex detector intended for Belle II 2 layers of PXD (pixel-type detectors: DEPFET's) and 4 "barrel-type" layers of SVD & 3 "barrel-slanted-type" layers of SVD (strip-type double sided detectors: DSSDs)
- Marlin&MarlinReco: new digitizer & clusterizer written, used for very realistic simulation of strip detector response (SimTrackerHit → TrackerPulse → TrackerHit)
 - *SiStripDigi* Marlin processor simulating response of a strip detector; processor digitizes simulated signals and provides electrical pulses on each strip
 - SiStripClus Marlin processor calculating clusters from given pulses; processor is trying to find clusters based on seeds, looks for adjacent strips based on threshold cuts, calculates clusters and provides hit position and covariance matrix
 - MaterialDB Marlin processor provides material info for Kalman filter (currently implemented for SVDBelle only, written by Andreas Moll)

Mokka – Belle SVD Geometry

- SVDBelle: driver used for current Belle vertex detector (SVD version 2)
 - Description: 4 layers in barrel part arranged in wind-mill structure
 - <u>Active part</u>: Si layers \rightarrow Si ladders \rightarrow Si sensors DSSDs (300 μ m thick)
 - <u>Passive part</u>:
 - Si rims around sensors, i.e. passive Si part $(300\mu m \text{ thick})$
 - Kaptons (polyimide + copper)
 - Zylon ribs
 - CRFP bridge & rims

	R [mm]	# ladders #	* DSSDs
Strip layer 1 – barrel	20	6	2
Strip layer 2 – barrel	43.5	12	3
Strip layer 3 – barrel	70	18	5
Strip layer 4 – barrel	88	18	6



Mokka – Belle II SVD Geometry

- *VXDBelleII*: driver used for VXD of Belle II (pixel part: PXD & strip part: SVD)
 - <u>Description of SVD</u>: 4 layers in barrel part + 3 layers in "forward" region; all arranged in wind-mill structure; only silicon implemented now!
 VXDBellell: PXD+SVD front view
 - <u>Active part</u>: Si layers \rightarrow Si ladders \rightarrow Si sensors DSSDs (300 μ m thick)
 - <u>Passive part</u>: Si rims around sensors (300µm thick)

	R [mm]	# ladders #	<i>DSSDs</i>
Strip layer 31 – barrel	38	8	2
Strip layer 41 – barrel	80	10	2
Strip layer 42 – barrel-slanted	66	14	3
Strip layer 51 – barrel	115	17	4
Strip layer 52 – barrel-slanted	95.5	10	1
Strip layer 61 – barrel	140	14	1
Strip layer 62 – barrel-slanted	114	17	1



Marlin – SVD Digitizer & Clusterizer

- SiStripDigi + SiStripClus: MarlinReco strip digitizer & clusterizer
 - <u>Input:</u> LCIO SimTrackerHits → LCIO Tracker pulses → <u>Output:</u> LCIO TrackerHits + relations to MC particles & MC weights (more than 1 particle may contribute to the recon. signal)
 - <u>Geometry:</u> Mokka hits transformation (using Gear info) from global to local reference system
 - <u>Physical processes:</u>
 - Generation of e-h pairs along the path (3.65 eV)
 - Drift of e-h pairs in electric field
 - Diffusion of e-h pairs due to multiple collisions
 - Lorentz shift of e-h pairs in magnetic field
 - Calculation of mutual microstrip cross talk
 - Generation of noise: sensor, electronics ...
 - <u>Clustering:</u> (based on COG algorithm)
 - Cluster finding (seed strips + their neighbours) \rightarrow R-Phi & Z clusters combined into 2D clusters
 - Transformation of 2D clusters' position + cov. matrix back to global ref. system \rightarrow TrackerHits



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SVD Digitizer Details – El. Field & Drift

• Electric field of abrupt p-n junction:

 Instead of areas around the strips, the analytically expressible field of p-n junction:

$$E(z) = -\left(\frac{V + V_{dep}}{d} - \frac{2z}{d^2}V_{dep}\right)$$

is used, it's very similar to what one obtains when solving exact Poisson equation;

- Parameters:
$$V_{dep} = 60V, V_{bias} = 150, 200, 250V$$





- Drift of e-h pairs:
 - Represented by the eq. of motion (1st order ODE): $v(z) = \mu(E(z), T) \cdot E(z)$
 - The mobility depends on elec. field and sensor temperature:

$$\mu(E(z),T) = \left(\frac{\mu_s/E_c}{(1 + (E(z)/E_c)^{\beta})^{1/\beta}}\right)$$

- Mobility parameters: $\mu_{e}(T,e,h), E_{e}(T,e,h), \beta(T,e,h)$

- ODE integrated numerically using Romberg meth.

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SVD Digitizer Details – Diffusion & Lorentz shift

- Diffusion of e-h pairs:
 - *e*, resp. *h*, are during the drift diffused by multiple collisions, given by Gaussian law:

$$dN = \frac{N}{\sqrt{4\pi Dt(\vec{r})}} \exp(-\frac{\dot{r}^2}{4Dt(\vec{r})}) d\vec{r}$$
$$D = \left(\frac{kT}{q}\mu(E,T)\right)$$

where *D* denotes diffusivity given by Einstein relation and *t* the drift time





- Lorentz shift of e-h pairs due to mag. field:
 - *e*, resp. *h*, are during the drift deflected in magnetic field (Lorentz shift of charge carriers)

$$\tan(\vartheta_L) = \frac{\int_z^d \mu(E(z)) r B dz}{\int_z^d dz}$$

- wher r denotes so-called Hall factor, r(T,e,h)
- ODE integrated numerically using Romberg. meth.

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Simulation Studies

- Geometry: Belle VXD versus Belle II VXD
- Particle muon gun used:
 - Particle momentum: 0.5 GeV muons
 - Polar angle scan: in whole acceptance range, i.e. 20 150 degrees
 - Azimuthal angle: isotropic uniform smearing
- Digitizer settings:
 - Deplet. voltage = 60 V, bias voltage = 150 V, temperature = 300 K
 - AC coupling = 120 pF, interstrip coupling = 6 pF, noise = 1000 e
- Method:
 - Resolution: calculated as RMS from obtained residuals (residual = reconstructed hits MC generated hits)
 - Cluster size: calculated as a number of strips above threshold set (seed $\sim 5 \times 10^{-100}$ neighbours $\sim 2 \times 10^{-100}$ noise, total signal $\sim 7 \times 10^{-100}$ noise)

Preliminary Results: Belle x Belle II SVD Resolution



Preliminary Results: Belle x Belle II SVD Cluster Size



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Summary & Future Plans

• Simulation software status:

- Mokka:
 - SVDBelle realistic geometry model of current Belle SVD prepared in Geant4 (OK)
 - VXDBelleII realistic geometry model of Belle II VXD (PXD+SVD) prepared in Geant4 still missing implem. of "dead" material in SVD (*OK*, *plan to implement SVD "dead" material*)

- MarlinReco:

- SiStripDigi realistic strip detector digitizer providing full simulation of DSSDs response (OK)
- SiStripClus clusterizer providing 2D hits (based on COG algorithm) (OK)
- MaterialDB for Belle processor providing material info for tracking code (Kalman filter) (OK)
- MaterialDB for BelleII not implemented yet (plan to implement)
- Tracking code (OK, except for SVD slanted parts, no plans currently)

• Simulation studies:

- First resolution studies performed & compared Belle wrt Belle II \rightarrow optimisation studies?
- First cluster size studies performed & compared Belle wrt Belle II \rightarrow optimisation studies?